

BG200B12UY3-I

IGBT Power Module

 V_{CE} =1200V I_{C} =200A

General Description

BYD IGBT Power Module BG200B12UY3-I provides fast switching characteristic as well as high short circuit capability, which introduce the advanced IGBT chip/FWD and improved connection.

Features

- High speed IGBT technology
- Including ultra fast & soft recovery anti-parallel FWD
- Low inductance
- Standard package
- High short circuit capability
- Fast switching and short tail current

Applications

- High frequency drivers
- AC motor control
- Inverters
- Servo
- UPS (Uninterruptible Power Supplies)
- Electric welding



Characteristic Values

Parameter	Symbol	Conditions	Temperature	Value	Unit					
Absolute Maximum Ratings										
Collector-emitter voltage	Vces	V _{GE} =0V	Tj =25 ℃	1200	V					
Continuous collector current	lc	_	Tc=80°C	200	Α					
Peak collector current	I _{CRM}	I _{CRM} =2I _C ,tp=1ms	_	400	Α					
Gate-emitter voltage	V _{GES}	_	_	+/-20	V					
Total power dissipation	P _{tot}	per switch (IGBT)	T _C =25°C	1040	W					
IGBT short circuit SOA	t _{psc}	V _{CC} =600V, V _{GE} ≤15V V _{CES} ≤1200V	T _{vj} ≤125°C	10	us					
Max. junction temperature	T _{vj max}	_	_	150	$^{\circ}$ C					
Operation junction temperature	T _{vj op}	_	_	-40~125	$^{\circ}$					
Storage temperature range	T _{stg}	_	_	-40~125	$^{\circ}$ C					
Diode DC forward current	I _F	_	T _C =80°C	200	Α					
Peak forward current	I _{FRM}	I _{FRM} =2I _F ,tp=1ms	_	400	Α					
I ² t-value, Diode	l²t	V _R =0V,t=10ms	Tj=125℃	_	A ² s					
Isolation voltage	Visol	t=1min,f=50Hz	_	2500	V					

Parameter	Symbol	Conditions	Temperature	Value			Unit
		Characteristics	l	I			
IGBT				min.	typ.	max.	
Gate-emitter threshold voltage	$V_{\text{GE(th)}}$	V _{GE} =V _{CE} , I _C = 3mA	T _{vj} =25℃	5.0	5.8	6.5	V
Collector-emitter cut-off current	Ices	V _{CE} =1200V,V _{GE} =0V	T _{vj} =25℃	_	_	1	mA
			T _{vj} =125℃	_	_	10	mA
Gate-emitter cut-off current	I _{GES}	V _{CE} =0V,V _{GE} =±20V	T _{vj} =25℃	-400		400	nA
Collector-emitter	N/	Ic=200A,V _{GE} =15V	T _{vj} =25℃	_	2.8	_	V
saturation voltage	V _{CE(sat)}		T _{vj} =125℃	_	3.5	_	V
Integrated gate resistor	R _{Gint}	_	T _{vj} =25℃	_	tbd	_	Ω
Total Gate Charge	Q_g	V _{CE} =600V,I _C =200A, V _{GE} =0V+15V	_	_	1.28	_	uC
Gate-Emitter Charge	Qge		_	_	0.22	_	uC
Gate-Collector Charge	Qgc		_	_	0.80	_	uC
Input capacitance	Cies	V _{CE} =25V,V _{GE} =0V, f=1MHz	T _{vj} =25°C	_	tbd	_	nF
Output capacitance	Coes			_	tbd	_	nF
Reverse transfer capacitance	Cres			_	tbd	_	nF
Turn-on delay time	t _{d(on)}	$V_{\text{CC}}\text{=}600\text{V}, I_{\text{C}}\text{=}200\text{A},$ $R_{\text{Gon}}\text{=}R_{\text{Goff}}\text{=}3.3\Omega,$ $V_{\text{GE}}\text{=}\pm15\text{V},$ $L_{\sigma}\text{=}80\text{nH},$ Inductive load	T _{vj} =25℃	_	224	_	ns
			T _{vj} =125℃	_	210	_	ns
Rise time	tr		T _{vj} =25℃	_	91	_	ns
	u u		T _{vj} =125℃	_	84	_	ns
Turn-off delay time	t _{d(off)}		T _{vj} =25℃	_	400	_	ns
			T _{vj} =125℃	_	460	_	ns
Fall time	t _f		T _{vj} =25℃	_	140	_	ns
	ď		T _{vj} =125℃	_	200	_	ns
Energy dissipation during turn-on time	Eon	$ \begin{array}{c c} V_{\text{CC}}\text{=}600\text{V}, \text{ Ic}\text{=}200\text{A}, \\ R_{\text{Gon}}\text{=}3.3\Omega, V_{\text{GE}}\text{=}\pm15\text{V}, \\ L_{\sigma}\text{=}80\text{nH}, \\ \text{Inductive load} \\ \end{array} \begin{array}{c} T_{\nu j}\text{=}25^{\circ}\text{C} \\ \\ T_{\nu j}\text{=}125^{\circ}\text{C} \end{array} $	T _{vj} =25℃	_	13.9	_	mJ
			T _{vj} =125℃	_	17.8	_	mJ
Energy dissipation during turn-off time	E _{off}	V_{CC} =600V, I_{C} =200A, R_{Goff} =3.3 Ω , V_{GE} =±15V	T _{vj} =25℃	_	10.9	_	mJ
		L _σ =80nH, Inductive load	T _{vj} =125℃		15.8		mJ

Parameter	Symbol	Conditions	Temperature	Value		Unit		
Diode			L	min.	typ.	max.		
Forward voltage	VF	I _F =200A	T _{vj} =25℃	_	1.8	_	V	
			T _{vj} =125℃	_	1.8	_	٧	
Peak reverse recovery current	I _{RR}	I _F =200A,V _R =600V, di _F /dt=1100/us	T _{vj} =125℃	_	160	_	Α	
Recovered charge	Qrr		T _{vj} =125℃	_	28.4	_	uC	
Reverse recovery time	trr		T _{vj} =125℃	_	370	_	ns	
Reverse recovery energy	Erec		T _{vj} =125℃	_	10.5	_	mJ	
Thermal-Mechanical Specifications								
IGBT thermal resistance junction to case	R _{th(j-c)}	per IGBT		_	_	0.12	K/W	
Diode thermal resistance junction to case	R _{th(j-c)}	per diode		_	_	0.2	K/W	
Thermal resistance case to heat-sink	R _{th(c-s)}	per module		_	0.03	_	K/W	
Dimensions	LxWxH	Typical , see outline drawing		106.4 x 61.4 x 31.5			mm	
Clearance distance in air	da	60664-1 and EN	Term. to base:	_	_	28.3	mm	
			Term. to term:	6.0	_	_		
Surface creepage distance	ds	60664-1 and EN	Term. to base:	_	24	_		
			Term. to term:	_	14	_	mm	
Mass	m	_	_		320		g	

Thermal and mechanical properties according to IEC 60747–15

Specification according to the valid application note.

Characterization Curves

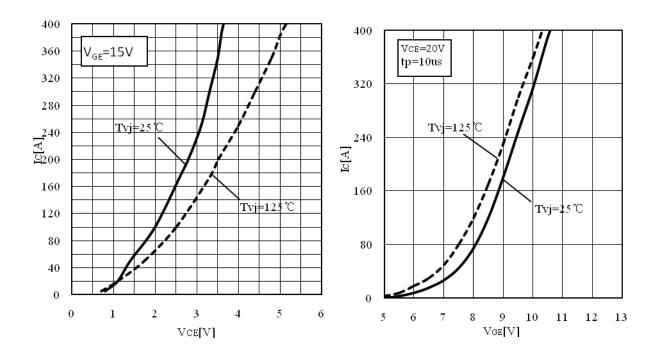


Fig.1 Typ. On-state Characteristics

Fig.2 Typ. Transfer Characteristics

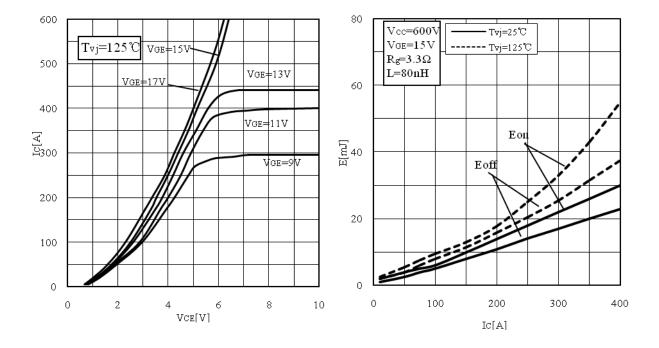
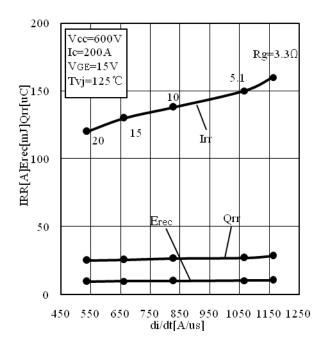


Fig.3 Typ. Output Characteristics

Fig.4 Switching Loss vs. Collector Current



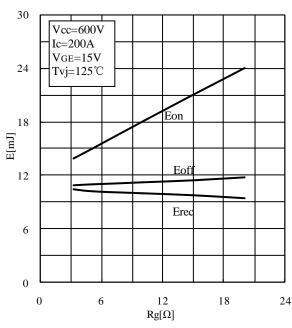
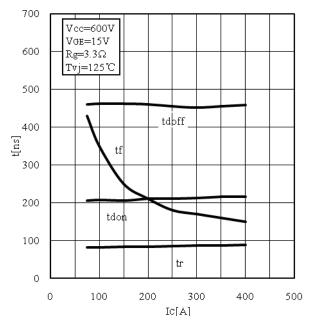


Fig.5 Typ. Reverse Recovery Characteristics vs di/dt

Fig.6 Switching Loss vs. Gate Resistor



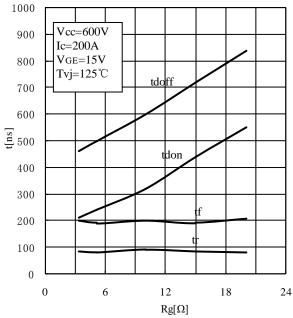


Fig.7 Typ. Switching Times vs. Ic

Fig.8 Typ. Switching Times vs. Gate Resistor R_G

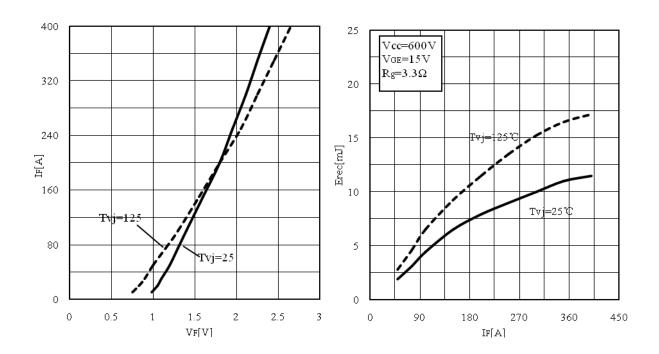


Fig.9 FWD Forward Characteristics.

Fig.10 Typ. Switching Losses Diode-Inverter

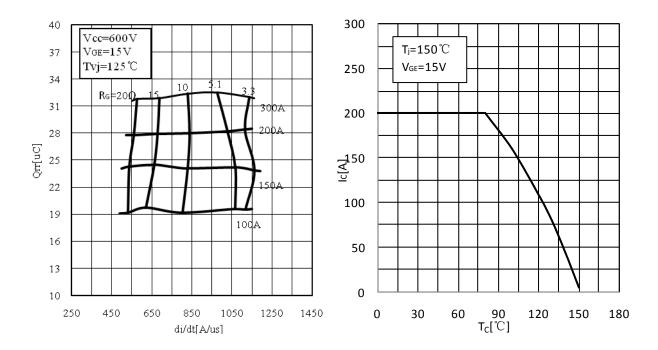


Fig.11 Typ. FRD Recovery Charge

Fig. 12 Rate Current vs. Temperature (Tc)

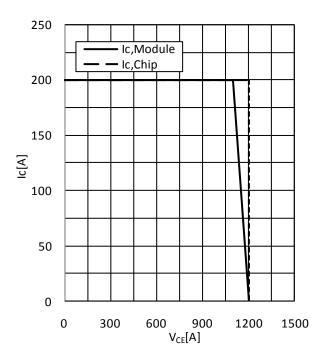
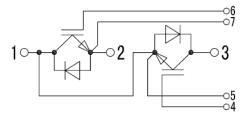


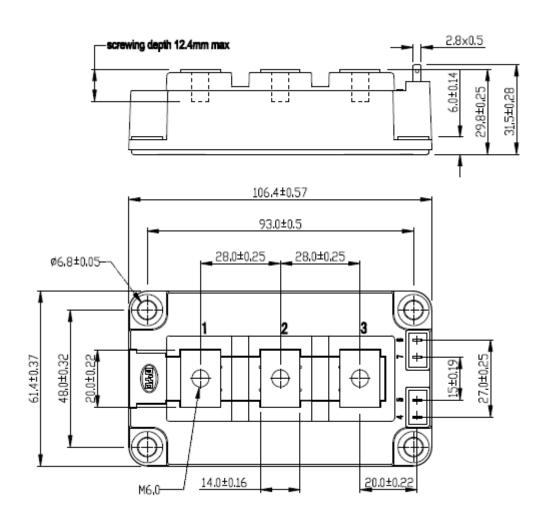
Fig.13 Reverse Bias Safe Operating Area IGBT-inv(RBSOA)

Circuit Diagram



Package Outlines

Dimensions in mm



Attached (recommended torque):

 M_S : (to heat sink M6) 3~6 Nm M_t : (to terminals M6) 2.5~5 Nm

Attention

- 1. In order to reduce the contact resistance, we suggest add thermal grease between base and heat-sink, which thickness is about 0.1mm.
- 2. When installing the module, please wear a electrostatic bracelet to prevent the gate breakdown and the imbalance power may damage the internal chip, even to damage the module.
- 3. This is an electrostatic sensitive device, please observe the international standard IEC 60747-1, chap. IX.

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